CNZ1109 (ON1109)

Photo Interrupter

For contactless SW, object detection

■ Overview

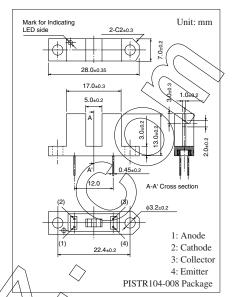
CNZ1109 is a photocoupler in which a high efficiency GaAs infrared light emitting diode is used as the light emitting element, and a high sensitivity phototransistor is used as the light detecting element. The two elements are arranged so as to face each other, and objects passing between them are detected.

■ Features

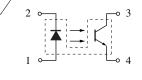
- Highly precise position detection: 0.7 mm
- Fast response t_r , $t_f = 6 \mu s$ (typ.)
- Small output current variation against change in temperature
- Deep and wide gap between emitting and detecting elements

■ Absolute Maximum Ratings $T_a = 25$ °C

	Symbol	Rating	Unit	
Input (Light	Reverse voltage	V _R	3	N
emitting diode)	Forward current	I_F	50	mA
	Power dissipation *1	P_{D}	75	mW(
Output (Photo	Collector-emitter voltage	V _{CEO}	30	v
transistor)	(Base open)		,	// `
	Emitter-collector voltage	V _{ECO}	5	V
	(Base open)			
	Collector current	I_C	20	mA
	Collector power dissipation *2	P _C	100 \	mW
Temperature	Operating ambient temperature	Topr	-25 to +85	°C
	Storage temperature	Tstg	-30 to +100	°C
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Internal Connection



Note) *1: Input power derating ratio is 1.0 mW/°C at $T_a \ge 25$ °C.

*2: Output power derating ratio is 1.34 mW/°C at $T_a \ge 25$ °C.

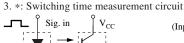
■ Electrical-Optical Characteristics $T_a = 25^{\circ}\text{C} \pm 3^{\circ}\text{C}$

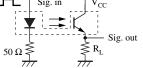
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	Parameter	Symbol	7	Conditions	Min	Тур	Max	Unit
Input	Forward voltage	V _F	I	50 mA		1.2	1.5	V
characteristics	Reverse current	I_R	V_R	= 3 V			10	μΑ
Output	Collector-emitter cutoff current	$\sqrt{I_{CEO}}$	V _{CI}	E = 10 V			200	nA
characteristics	(Base open)	\bigvee						
	Collector-emitter capacitance	C _C	V_{CI}	g = 10 V, f = 1 MHz		5		pF
Transfer	Collector current	I_C	I _F =	$= 50 \text{ mA}, I_C = 0.1 \text{ mA}$	0.3			mA
characteristics	Collector-emitter saturation voltage	V _{CE(sat)}	I _F =	$= 50 \text{ mA}, I_C = 1 \text{ mA}$			0.3	V
	Rise time	t _r	V _C	$_{\rm C} = 10 \text{ V}, I_{\rm C} = 1 \text{ mA}, R_{\rm L} = 100 \Omega$		6.0		μs
	Fall time	$t_{\rm f}$				6.0		μs

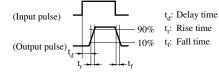
Note) 1. Input and output are practiced

by electricity

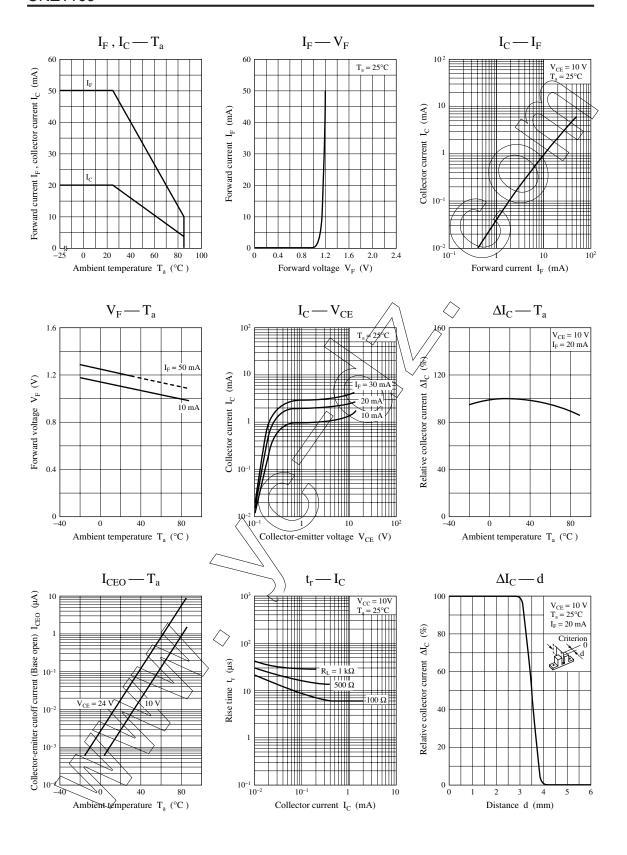
2. This device is designed be disregarded radiation.







Note) The part number in the parenthesis shows conventional part number.



Caution for Safety

⚠ DANGER

■ This product contains Gallium Arsenide (GaAs).

GaAs powder and vapor are hazardous to human health if inhaled or ingested. Do not burn, destroy, cut, cleave off, or chemically dissolve the product. Follow related laws and ordinances for disposal. The product should be excluded form general industrial waste or household garbage.

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physical injury fire social damages, for example, by using the products.

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